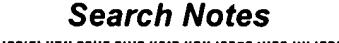


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/622,733	LU ET AL.
	Examiner	Art Unit
	Nhan T. Tran	2622

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) (text search - see search history printout)	10/6/2006	NT
348/294-299 (text search - see search history printout)	10/9/2006	NT
348/229.1, 294-324, 362 (text search - see search history printout)	10/10/2006	NT
Inventorship search - see search history printout	10/13/2006	NT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner